Notice of References Cited Application/Control No. 10/561,818 Examiner JAMES N. SMALLEY Applicant(s)/Patent Under Reexamination GRANGER ET AL. Art Unit Page 1 of 1

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	U	List of material densities, http://www.simetric.co.uk					
	V	Appendix A, Examiner's annotated drawing					
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.